Random bad cell map for wafer 238 s/n: 21316-16-13

Date: 12/17/99

		0	0	0	0	0		
		0	0	0				
	20	0	0	0	0	0	0	
	0		0	0	0	0	3	
17	0	0	0	1	0	0		
0	0	0	0	0	0	0	0	0
52		0	0	0	0	356	0	
0	4	4	0		0	0	0	0
0		0		0		0	0	
0		0	0	0	0	0	0	
0	0	0	0	0	0	0		
0	1	0	0	0	0	0	0	0
0	0	0	0	0	0	0	0	
0	0	0	0	0	0		0	
	0		0	0	1			
	0	0	0	0	1	13		
		0	6	0		0		
		0	0	0	25	0		

#	Number of bad cells in random locations
	No info